TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74VCX2373FT, TC74VCX2373FK

Low-Voltage Octal D-Type Latch with 3.6-V Tolerant Inputs and Outputs

The TC74VCX2373 is a high-performance CMOS octal D-type latch. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to  $3.6\ V.$ 

This 8 bit D-type latch is controlled by a latch enable input (LE) and a output enable input ( $\overline{OE}$ ). When the  $\overline{OE}$  input is high, the eight outputs are in a high-impedance state. The 26- $\Omega$  series resistor helps reducing output overshoot and undershoot without external resistor.

All inputs are equipped with protection circuits against static discharge.

#### **Features**

- 26-Ω series resistors on outputs.
- Low-voltage operation: V<sub>CC</sub> = 1.8 to 3.6 V
- High-speed operation:  $t_{pd} = 5.1 \text{ ns (max) (V}_{CC} = 3.0 \text{ to } 3.6 \text{ V)}$

 $t_{pd} = 6.1 \text{ ns (max) (V}_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

 $t_{pd} = 9.8 \text{ ns (max) (VCC} = 1.8 \text{ V)}$ 

• Output current: I<sub>OH</sub>/I<sub>OL</sub> = ±12 mA (min) (V<sub>CC</sub> = 3.0 V)

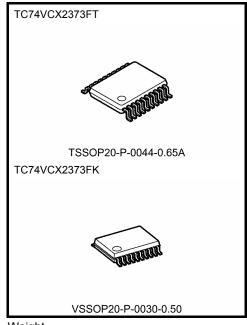
 $: I_{OH}/I_{OL} = \pm 8 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$ 

:  $I_{OH}/I_{OL} = \pm 4$  mA (min) ( $V_{CC} = 1.8$  V)

- Latch-up performance: -300 mA
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$

Human body model  $\geq \pm 2000 \text{ V}$ 

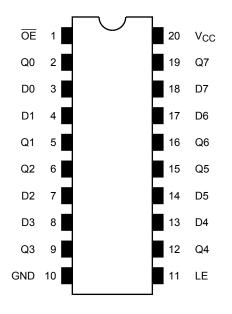
- Package: TSSOP and VSSOP (US)
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs



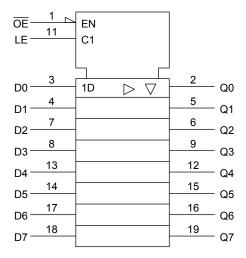
Weight

TSSOP20-P-0044-0.65A : 0.08 g (typ.) VSSOP20-P-0030-0.50 : 0.03 g (typ.)

### Pin Assignment (top view)



### **IEC Logic Symbol**



### **Truth Table**

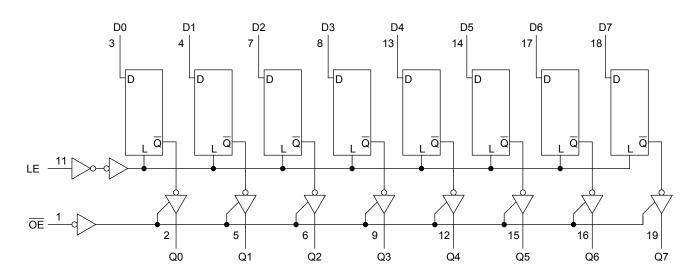
	Inputs	Outputs	
ŌĒ	LE	D	Outputs
Н	Х	Х	Z
L	L	Х	Qn
L	Н	L	L
L	Н	Н	Н

X: Don't care

Z: High impedance

Qn: Q outputs are latched at the time when the LE input is taken to a low logic level.

### **System Diagram**



### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5 to 4.6	V
DC input voltage	V <sub>IN</sub>	-0.5 to 4.6	V
		-0.5 to 4.6 (Note 2)	
DC output voltage	$V_{OUT}$	-0.5 to V <sub>CC</sub> + 0.5	V
		(Note 3)	
Input diode current	I <sub>IK</sub>	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	$P_{D}$	180	mW
DC V <sub>CC</sub> /ground current per supply pin	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$ 

### **Operating Ranges (Note 1)**

Characteristics	Characteristics Symbol Rating		Unit	
Power supply voltage	Voc	1.8 to 3.6	V	
Power supply voltage	V <sub>CC</sub>	1.2 to 3.6 (Note 2)	ľ	
Input voltage	VIN	-0.3 to 3.6	V	
Output voltage	Vout	0 to 3.6 (Note 3)	V	
Output voltage	VOU1	0 to V <sub>CC</sub> (Note 4)	V	
		±12 (Note 5)		
Output current	I <sub>OH</sub> /I <sub>OL</sub>	±8 (Note 6)	mA	
		±4 (Note 7)		
Operating temperature	T <sub>opr</sub>	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V	

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5:  $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$ 

Note 6:  $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

Note 7:  $V_{CC} = 1.8 \text{ V}$ 

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V



### **Electrical Characteristics**

# DC Characteristics (Ta = -40 to 85°C, 2.7 V < $V_{CC} \leq 3.6 \ V)$

Characterist	ics	Symbol	Test C	Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Innut voltage	H-level	$V_{IH}$	-		2.7 to 3.6	2.0	_	V
Input voltage	L-level	V <sub>IL</sub>	-	_	2.7 to 3.6	_	0.8	٧
				I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2	_	
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -6 \text{ mA}$	2.7	2.2	_	
				$I_{OH} = -8 \text{ mA}$	3.0	2.4	_	
Output voltage				$I_{OH} = -12 \text{ mA}$	3.0	2.2	_	V
	L-level V		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OL} = 100 \mu A$	2.7 to 3.6	_	0.2	
		V <sub>OL</sub>		$I_{OL} = 6 \text{ mA}$	2.7	_	0.4	
				$I_{OL} = 8 \text{ mA}$	3.0	_	0.55	
				$I_{OL} = 12 \text{ mA}$	3.0	_	0.8	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μΑ
2 state output OFF sta	ata aurrant	1	$V_{IN} = V_{IH}$ or $V_{IL}$	= V <sub>IH</sub> or V <sub>IL</sub>			110.0	^
3-state output OFF state current		loz	V <sub>OUT</sub> = 0 to 3.6 V		2.7 to 3.6	_	±10.0	μА
Power-off leakage current		loff	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 \	/	0	_	10.0	μА
0.:		Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7 to 3.6	_	20.0	
Quiescent supply curre	Quiescent supply current		$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		2.7 to 3.6	_	±20.0	μΑ
Increase in I <sub>CC</sub> per inp	out	Δl <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> - 0.6 V		2.7 to 3.6	_	750	

# DC Characteristics (Ta = -40 to 85°C, 2.3 V $\leq$ V<sub>CC</sub> $\leq$ 2.7 V)

Characte	ristics	Symbol	Test	t Condition	V <sub>CC</sub> (V)	Min	Max	Unit
	H-level	VIH		_	2.3 to 2.7	1.6	_	.,
Input voltage	L-level	V <sub>IL</sub>			2.3 to 2.7	_	0.7	V
				I <sub>OH</sub> = -100 μA	2.3 to 2.7	V <sub>CC</sub> - 0.2	_	
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -4 mA	2.3	2.0	_	
				I <sub>OH</sub> = -6 mA	2.3	1.8	_	V
Output voltage				I <sub>OH</sub> = -8 mA	2.3	1.7	_	
			$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 100 μA	2.3 to 2.7	_	0.2	
	L-level	V <sub>OL</sub>		I <sub>OL</sub> = 6 mA	2.3	_	0.4	
				I <sub>OL</sub> = 8 mA	2.3	_	0.6	
Input leakage curre	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μА
3-state output OFF state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		2.3 to 2.7		±10.0	μА
			V <sub>OUT</sub> = 0 to 3.6 V					
Power-off leakage of	current	loff	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μΑ
Quiescent supply current		Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3 to 2.7	_	20.0	μА
Gaiocociii Gappiy ol	un ont	100	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		2.3 to 2.7	_	±20.0	μιτ



# DC Characteristics (Ta = -40 to 85°C, 1.8 V $\leq$ V<sub>CC</sub> < 2.3 V)

Characteristics		Symbol Test Condition		_	Min	Max	Unit	
		- Cy	. 551 5	root condition				<b></b>
Input voltage	H-level	V <sub>IH</sub>	-	_	1.8 to 2.3	$\begin{array}{c} 0.7 \times \\ V_{CC} \end{array}$		V
input voltage	L-level	V <sub>IL</sub>	-	_	1.8 to 2.3	I	0.2 × V <sub>CC</sub>	V
	H-level	Voh	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.8	V <sub>CC</sub> - 0.2		
Output voltage				I <sub>OH</sub> = -4 mA	1.8	1.4	_	V
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 100 μA	1.8	_	0.2	
	L-level			I <sub>OL</sub> = 4 mA	1.8		0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.8	_	±5.0	μА
3-state output OFF state current		loz	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to 3.6 V		1.8	_	±10.0	μА
Power-off leakage current		l <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	_	10.0	μΑ
Quiocont aupply curre	ant .	lcc.	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.8	_	20.0	^
Quiescent supply curre	erit.		$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		1.8	_	±20.0	μА



# AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, $C_L$ = 30 pF, $R_L$ = 500 $\Omega$ ) (Note 1)

Characteristics	Symbol	Symbol Test Condition		Min	Max	Unit
Characteristics	Symbol Test Condition		V <sub>CC</sub> (V)	IVIIII	iviax	Offic
Propagation delay time	<b>.</b>		1.8	1.5	9.8	
(D-Q)	t <sub>pLH</sub>	Figure 1, Figure 2	$2.5 \pm 0.2$	8.0	6.1	ns
(D-Q)	фнг		$3.3 \pm 0.3$	0.6	5.1	
Dronagation dalay time	4		1.8	1.5	9.8	
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2	$2.5\pm0.2$	0.8	6.3	ns
(LE-Q)	t <sub>pHL</sub>		$3.3 \pm 0.3$	0.6	5.1	
			1.8	1.5	9.8	
3-state output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	$2.5\pm0.2$	0.8	6.5	ns
	t <sub>pZH</sub>		$3.3 \pm 0.3$	0.6	5.0	
		Figure 1, Figure 3	1.8	1.5	7.7	ns
3-state output disable time	t <sub>pLZ</sub>		$2.5\pm0.2$	0.8	4.3	
			$3.3 \pm 0.3$	0.6	3.9	
NACCE CONTRACTOR OF THE PROPERTY OF THE PROPER		Figure 1, Figure 2	1.8	4.0	_	
Minimum pulse width	t <sub>w (H)</sub>		$2.5 \pm 0.2$	1.5	_	ns
(LE)			$3.3 \pm 0.3$	1.5	_	
			1.8	2.5	_	
Minimum set-up time	ts	Figure 1, Figure 2	$2.5\pm0.2$	1.5	_	ns
			$3.3 \pm 0.3$	1.5	_	<b> </b>
			1.8	1.0	_	
Minimum hold time	t <sub>h</sub>	Figure 1, Figure 2	$2.5 \pm 0.2$	1.0	_	ns
			$3.3 \pm 0.3$	1.0	_	
			1.8	_	0.5	
Output to output skew	tosLH	(Note 2)	$2.5\pm0.2$	_	0.5	ns
	t <sub>osHL</sub>		$3.3 \pm 0.3$	_	0.5	

Note 1: For  $C_L = 50 \ pF$ , add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

### Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 1.8	0.15	
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V (Not	2.5	0.25	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 3.3	0.35	
	V <sub>OLV</sub>	$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 1.8	-0.15	V
Quiet output minimum dynamic $V_{OL}$		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	2.5	-0.25	
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 3.3	-0.35	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 1.8	1.55	
Quiet output minimum dynamic V <sub>OH</sub>	V <sub>OHV</sub>	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	2.5	2.05	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	3.3	2.65	

Note: Parameter guaranteed by design.

### **Capacitive Characteristics (Ta = 25°C)**

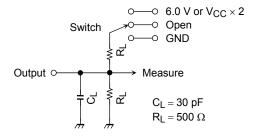
Characteristics	Symbol Test Condition			Tyro	Unit
Characteristics	Symbol	rest condition	V <sub>CC</sub> (V)	Тур.	Offic
Input capacitance	C <sub>IN</sub>	_	1.8, 2.5, 3.3	6	pF
Output capacitance	CO	_	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C <sub>PD</sub>	$f_{\text{IN}} = 10 \text{ MHz}$ (Note	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$ 

#### **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND

Figure 1

#### **AC Waveform**

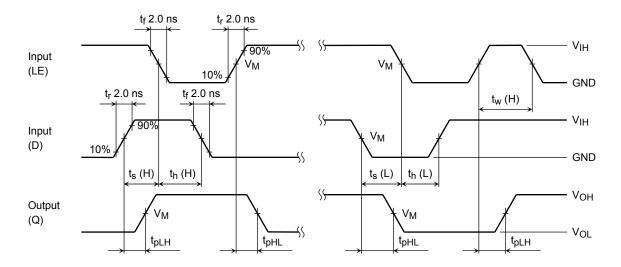


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>, t<sub>w</sub>, t<sub>s</sub>, t<sub>h</sub>

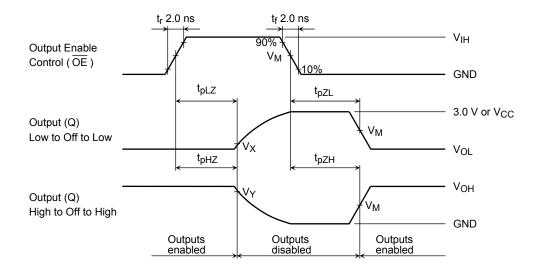


Figure 3 t<sub>pLZ</sub>, t<sub>pHZ</sub>, t<sub>pZL</sub>, t<sub>pZH</sub>

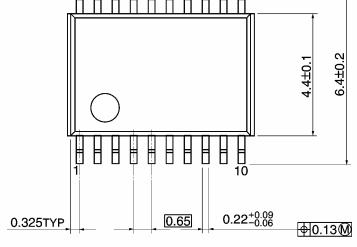
8

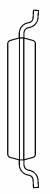
Symbol		V <sub>CC</sub>	-
Symbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2\textrm{V}$	1.8 V
V <sub>IH</sub>	2.7 V	V <sub>CC</sub>	V <sub>CC</sub>
V <sub>M</sub>	1.5 V	V <sub>CC</sub> /2	V <sub>CC</sub> /2
VX	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	V <sub>OL</sub> + 0.15 V
VY	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.15 V

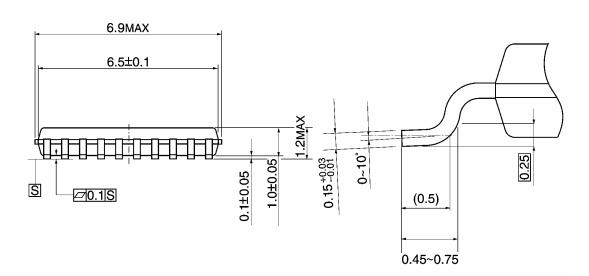
# **Package Dimensions**

TSSOP20-P-0044-0.65A

Unit: mm



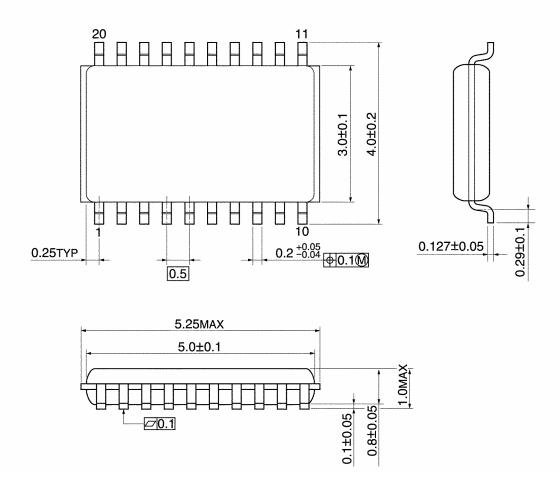




Weight: 0.08 g (typ.)

# **Package Dimensions**

VSSOP20-P-0030-0.50 Unit: mm



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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